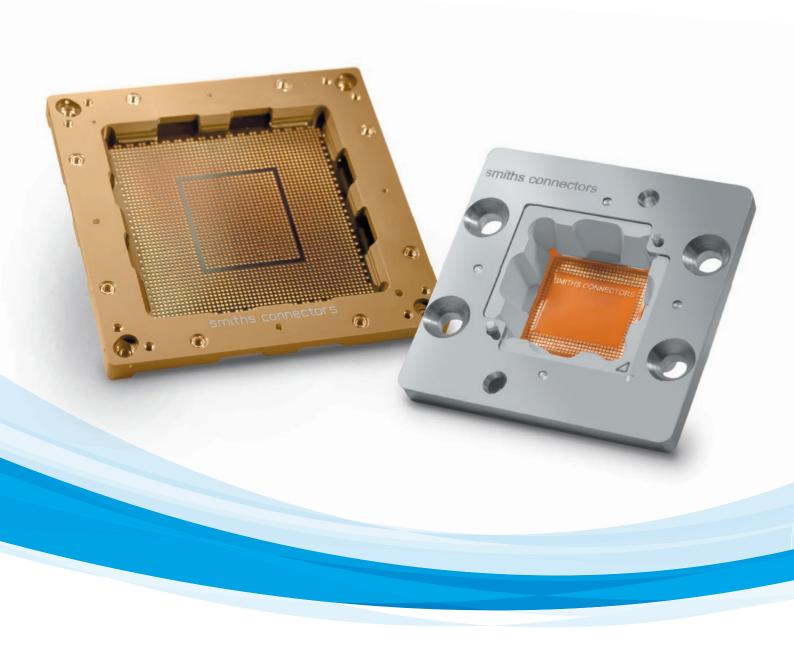
smiths connectors

SILMAT® TEST SOCKET

Elastomeric Solutions for Digital High Speed & PoP Top Test



Uniting the unparalleled attributes of Silmat® Elastomeric Contacts with the best-in-class engineering and test development practices of Smiths Connectors







FEATURES & BENEFITS

Patented, low profile contact

- ▶ Solderless memory replacement
- Short signal path
- Conformal to recessed LGAs

High speed signal integrity

- ▶ Electrically transparent contact
- ▶ High frequency bandwidth > 40 GHz
- Low inductance

Durability

- ▶ Long cycle life > 500,000 cycles
- ▶ No PCB or solder ball damage
- Minimal labour and tester downtime

Engineering expertise

- Monte Carlo Analysis
- ▶ Thermal Analysis
- ▶ RF Simulation

The Next Generation of Test Solutions

Smiths Connectors, a leading supplier of high reliability test solutions, is introducing the Silmat® elastomeric contact to our technology portfolio. The patented, low profile contact is engineered specifically to provide electrical and mechanical advantages in the Digital High Speed and PoP Top segments of the Semiconductor Test industry.

Smiths Connectors' best-in-class engineering, test development expertise and commitment to excellence allows us to continuously invest in innovative technologies and solutions for the testing requirements of next generation devices.

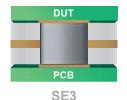
TECHNICAL CHARACTERISTICS







SC4



High Performance Contacts 2 piece system: 2 piece system: 1 piece system: contact set and elastomer contact set and elastomer elastomer **Package Types** All package types and sizes, full and partial array capabilities Package Size 50 mm x 50 mm 30 mm x 30 mm 30 mm x 30 mm RF / Microwave, Power, System Level **Recommended Applications** RF / Microwave. Power. RF / Microwave. Power. Device System Level Test, ATE HVM Test, ATE HVM, High Compliance Characterisation, Low Cycle

MECHANICAL & ENVIRONMENTAL

Minimum Pitch	0.5 mm	0.4 mm	0.3 mm
Compliance / Travel	0.40 mm	0.28 mm	0.23 mm
Operating Temperature	-55°C to 155°C	-55°C to 155°C	-55°C to 200°C
Gold Contact Set Expected Life	> 2,000,000	> 2,000,000	_
Elastomeric Interposer Expected Life	> 500,000	> 500,000	> 1,000-100,000

ELECTRICAL

Inductance (Self / Mutual)	0.33 nH / 0.15 nH	< 0.15 nH / 0.05 nH	0.10 nH / 0.02 nH
Capacitance (Self / Mutual)	0.20 pF / 0.05 pF	0.15 pF / 0.02 pF	0.14 pF / 0.01 pF
Contact Resistance	< 25 mΩ	< 25 mΩ	< 25 mΩ
Current Capacity	4 A @ 14°C rise	4 A @ 14°C rise	4 A @ 14°C rise
Bandwidth	Up to 40 GHz	> 40 GHz	> 40 GHz









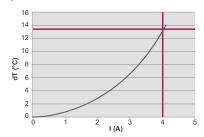
PERFORMANCE

CURRENT CARRYING CAPACITY

- > Provides higher current at lower temperature rise as compared to spring probe (3 Amps) and competitive elastomeric solutions (< 2 Amps)
- Characterization data for 0.5 mm contact structure

4 AMPS @ 14°C TEMPERATURE RISE(1)

Temperature Rise as a Function of Drive Current I

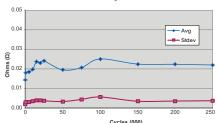


CONTACT RESISTANCE

▶ 0.5 mm pitch

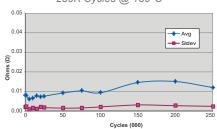
AMBIENT TESTING

250K Cycles



HOT TESTING

250K Cycles @ 150°C

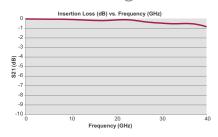


BANDWIDTH & FREQUENCY RESPONSE

▶ 0.5 mm pitch

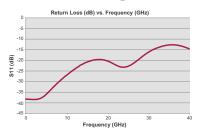
INSERTION LOSS (S21)

Better than -1 dB @ 40 GHz(1)



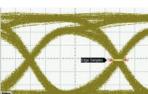
RETURN LOSS (S11)

Better than -12 dB @ 40 GHz(1)



EYE DIAGRAM

- ▶ 28 Gbps application
- ▶ EYE Pattern is similar between device tested in Silmat® Socket and soldered down environments
- Pattern: PRBS 29



SOCKETED

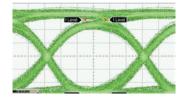
EYE Diagram

SOLDERED DOWN

EYE Diagram







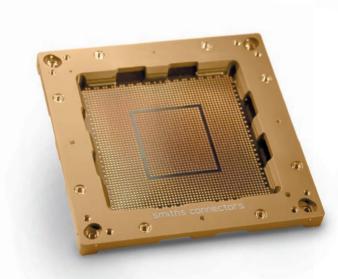
MEASURED DATA

SOCKETED SOLDERED DOWN	SOLDERED DOWN
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Deterministic Jitter	3.58 ps	4.04 ps	
Random Jitter	0.238 ps	0.234 ps	
Inter Symbol Interference	4.02 ps	4.13 ps	
Rise Time (20%-80%)	18.40 ps	17.50 ps	
Fall Time (20%-80%)	15.10 ps	14.80 ps	
EYE Amperage	550 mV	571 mV	
Input Voltage	800 mVpp	800 mVpp	



APPLICATIONS





DIGITAL HIGH SPEED





- ▶ Electrically transparent interconnect
 - ▶ Enables system level and ATE testing to full speed
- More bandwidth available for other test hardware
- Minimal signal distortion
 - ▶ Ensuring reliable measurement
- ▶ Enables clean power delivery

PACKAGE-ON-PACKAGE TOP





- Conformal contacts for recessed pads
 - Accommodates device tolerance misalignment
- Provides soldered memory performance level while eliminating the memory soldering/ desoldering operation
- Reduced cost of ownership
 - ▶ Offers maximised equipment utilisation
 - Minimised labour requirement

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